	, (IDA					ATTY DOCKET NO. 50060-00040	s	SERIAL NO. 09/840,716		
••	INF	ORMA	TION DISCLOSURE se several sheets if necess	CTTAZYON		SNIEGOWSKI ET AL				
•		(U	SO SOVERIA STREAMS IT NECESS	2000		FILING 4/23/01		GROUP 1765		
			ا سا	≥/	PATENT	DOCUMENTS			1703	
EXAMINER		DOCUMENT NUMBER		DATE	NAME		CLASS	SUBCLASS	FILING DATE	πE
INITIAL /	A	5,766,367		6/16/98 SMITH		ET AL	134	2		
	В	5,783,340		7/21/98	FARIN	O ET AL	430	22		
	С	5,798,283		8/25/98	MONT	AGUE ET AL	438	24		
	D	5,804,084		9/8/98	NASBY	ET AL	216	2		
	E	5,867,302		2/2/99	FLEM	ING	359	291		
	F	5,919,548		7/6/99	BARR	ON ET AL	428	138		
	G	5,95	55,801	9/21/99	ROME	RO ET AL	310	40 MM		
	Н	5,95	59,376	9/28/99	ALLE	V	310	40 MM		
	ī	5,90	53,788	10/5/99	BARR	ON ET AL	438	48		
	J	5,99	90,473	11/23/99	DICKI	EY ET AL	250	231.13		
ĹV	к	5,994,801		11/30/99	GARCIA		310	40 MM		
				FORE	EIGN PATI	ENT DOCUMENTS				
			DOCUMENT NUMBER	DATE		COUNTRY	CLASS	EUBCLASS	TRANSLA YES	NO ON
						Q'		1001		
							oct	100		
							<b>10</b>	`		
							•			
			OTHER DOCUM	ENTS (Includi	ng Autho	or, Title, Date, Pertinent	Pages, Etc.	)		
ĽV	NEE ET AL; "STRETCHED-FILM MICROMIRRORS FOR IMPROVED OPTICAL FLATNESS"; JANUARY, 2000 IEEE MEMS - 2000 CONFERENCE, MIYAZAKI, JAPAN								2000	
		1								
EXAMIN	ER	<u> </u>				DATE CONSIDERED	2/11/	a 1		
			AN VINH				3/11/			
			eference considered, wheth			mance with MPEP 609; Draw	line through o	citation if not in	contormance a	and not

Form PTO-A820 (also form PTO-1449)

P09C/REV03

Patent and Trademark Office \* U.S. DEPARTMENT OF COMMERCE

				Docket Number (Optional)		Application Number				
	<del>h</del> vno	ment on recy course	E CITATION	50060-00040 Applicant(s)		09/840,716				
	INFO	(Use several sheets if necess	e CITATION ary)	SNIEGOWSKI ET AL.						
		~\		Filing Date Group Art Unit			1865			
	13.	OCT 1 4 2003 2			4/23/01		1765			
U.S. PATENT DOCUMENTS										
*EXAMINER INITIAL	REF	ADELIMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	FILING DATE  IF APPROPRIATE		
LV	AA	6,600,587	7/29/03	SNIEG	OWSKI ET AL.	359	223	4/23/01		
								NED		
		-					P	ECEIVED OCT 2 1 2003 TC 1700		
								OCT 2 1 200		
								10 1109		
,								·		
	,									
		· · · · · · · · · · · · · · · · · · ·								
FOREIGN PATENT DOCUMENTS										
	REF	EF DOCUMENT NUMBER DATE		COUNTRY		CLASS	SUBCLASS	Translation YES NO		
<del> </del>										
				1						
· <u>-</u>		1	<u> </u>	OTHER	DOCUMENTS (Includir	ng Author, Title	, Date, Pertinent P	ages, Etc.)		
	.									
	$\dashv$									
EXAMINI	ER /	AV VINH		DATE CONSIDERED 3/11/04						
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and										
EXAMINI not consid	ER: Init ered. I	tial if citation considered, whethe nclude copy of this form with ne	er or not citation is in the communication to	o applicant.	nce with Mirer Section 003	, DIAW HHE U	i Anku ewamon it ili	or in contormance and		